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09/624,014	07/21/2000	Hideaki Sakaguchi	1152-0263P	4601

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EXAMINER

BARAN, MARY C

ART UNIT PAPER NUMBER

2857

DATE MAILED: 09/11/2002

Please find below and/or attached an Office communication concerning this application or proceeding.

Office Action Summary

Application No.

09/624,014

Applicant(s)

SAKAGUCHI, HIDEAKI

Examiner

Mary Kate B Baran

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-- The MAILING DATE of this communication appears on the cover sheet with the correspondence address --

Period for Reply

A SHORTENED STATUTORY PERIOD FOR REPLY IS SET TO EXPIRE 3 MONTH(S) FROM THE MAILING DATE OF THIS COMMUNICATION.

- Extensions of time may be available under the provisions of 37 CFR 1.136(a). In no event, however, may a reply be timely filed after SIX (6) MONTHS from the mailing date of this communication.
- If the period for reply specified above is less than thirty (30) days, a reply within the statutory minimum of thirty (30) days will be considered timely.
- If NO period for reply is specified above, the maximum statutory period will apply and will expire SIX (6) MONTHS from the mailing date of this communication.
- Failure to reply within the set or extended period for reply will, by statute, cause the application to become ABANDONED (35 U.S.C. § 133).
- Any reply received by the Office later than three months after the mailing date of this communication, even if timely filed, may reduce any earned patent term adjustment. See 37 CFR 1.704(b).

Status

- 1) ☒ Responsive to communication(s) filed on 25 October 2000.
- 2a) ☐ This action is **FINAL**. 2b) ☒ This action is non-final.
- 3) ☐ Since this application is in condition for allowance except for formal matters, prosecution as to the merits is closed in accordance with the practice under *Ex parte Quayle*, 1935 C.D. 11, 453 O.G. 213.

Disposition of Claims

- 4) ☒ Claim(s) 1-11 is/are pending in the application.
- 4a) Of the above claim(s) _____ is/are withdrawn from consideration.
- 5) ☐ Claim(s) _____ is/are allowed.
- 6) ☒ Claim(s) 1-11 is/are rejected.
- 7) ☐ Claim(s) _____ is/are objected to.
- 8) ☐ Claim(s) _____ are subject to restriction and/or election requirement.

Application Papers

- 9) ☒ The specification is objected to by the Examiner.
- 10) ☐ The drawing(s) filed on _____ is/are: a) ☐ accepted or b) ☐ objected to by the Examiner.
- Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).
- 11) ☐ The proposed drawing correction filed on _____ is: a) ☐ approved b) ☐ disapproved by the Examiner.
- If approved, corrected drawings are required in reply to this Office action.
- 12) ☐ The oath or declaration is objected to by the Examiner.

Priority under 35 U.S.C. §§ 119 and 120

- 13) ☒ Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).
- a) ☒ All b) ☐ Some * c) ☐ None of:
1. ☐ Certified copies of the priority documents have been received.
2. ☐ Certified copies of the priority documents have been received in Application No. _____.
3. ☐ Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).
- * See the attached detailed Office action for a list of the certified copies not received.
- 14) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. § 119(e) (to a provisional application).
- a) ☐ The translation of the foreign language provisional application has been received.
- 15) ☐ Acknowledgment is made of a claim for domestic priority under 35 U.S.C. §§ 120 and/or 121.

Attachment(s)

- 1) ☒ Notice of References Cited (PTO-892)
- 2) ☐ Notice of Draftsperson's Patent Drawing Review (PTO-948)
- 3) ☒ Information Disclosure Statement(s) (PTO-1449) Paper No(s) 4.
- 4) ☐ Interview Summary (PTO-413) Paper No(s) _____.
- 5) ☐ Notice of Informal Patent Application (PTO-152)
- 6) ☐ Other: _____.

DETAILED ACTION

Specification

1. The disclosure is objected to because of the following informalities: the term "outputs", page 10 line 24, page 12 line 21, should be – output –. The phrase "as a defective", page 23 line 2, page 24 line 9, should be – as defective –.

Appropriate correction is required.

Claim Objections

2. Claims 8 and 9 are objected to because of the following informalities: the term "outputs", claim 8 line 14, claim 9 line 11, should be – output –. Appropriate correction is required.

Claim Rejections - 35 USC § 112

3. The following is a quotation of the second paragraph of 35 U.S.C. 112:

The specification shall conclude with one or more claims particularly pointing out and distinctly claiming the subject matter which the applicant regards as his invention.

Claims 3-11 are rejected under 35 U.S.C. 112, second paragraph, as being indefinite for failing to particularly point out and distinctly claim the subject matter which applicant regards as the invention.

Referring to claims 3-7, it is unclear as to whether the Applicant is claiming a testing method or a testing device.

Referring to claims 8-11, it is unclear as to whether the Applicant is claiming a storage device, a testing method or a testing device.

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Claim Rejections - 35 USC § 103

4. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:

(a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negated by the manner in which the invention was made.

Claims 1 and 2 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yamagami et al. (U.S. Patent No. 6,121,786) and Paulos et al. (U.S. Patent No. 6,091,350) in view of Cheng (U.S. Patent No. 6,154,041).

Referring to claim 1, Yamagami et al. discloses multiple voltage outputs associated with multiple voltage terminals (see Yamagami et al., col. 8 lines 39-40 and Figure 5, "VREF1, VREF2, VEXT"), a reference voltage generator which generates a multiple number of reference voltages to be compared to each output voltage output from each of the output terminals (see Yamagami et al., col. 8 lines 39-47), a multiple number of differential amplifiers (see Figure 5, "differential amplifier 7"), each having two input terminals (see Figure 5, "VREF1, VREF2, VEXT, differential amplifier 7"), one for receiving the output voltage output from the associated output terminal (see Figure 5, "VEXT") and the other for receiving the reference voltage from the reference voltage generator (see Yamagami et al., col. 9 line 54 – col. 10 line 2 and Figure 5, "VREF1, VREF2") and a comparator that receives the amplified output voltages from the multiple number of differential amplifiers (see Yamagami et al., col. 11 lines 24-29) and judges whether the amplified output voltage from each of the differential amplifiers falls within a given voltage range (see Yamagami et al., col. 11 lines 39-47). Yamagami et al. does

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not teach D/A converters as a reference voltage generator, or selectively outputting multiple sets of reference voltages.

Cheng discloses a D/A converter as a reference voltage generator (see Cheng, col. 5 lines 48-62).

Paulos et al. discloses selectively outputting a range of voltages based on a given input voltage (see Paulos et al., col. 3 lines 44-52).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the teachings of Yamagami et al. to include the teachings of Cheng because using a D/A converter as a voltage generator allows the skilled artisan to produce a continuous waveform with no large current jumps (see Cheng, col. 4 lines 23-27), and to further include the teachings of Paulos et al. because outputting a set of voltages allows the skilled artisan to effectively use the available supply voltage (see Paulos et al., col. 1 line 66 – col. 2 line 3).

Referring to claim 2, Yamagami et al. teaches outputting multiple reference voltages (see Yagamani et al., col. 9 lines 50-53), but does not teach a D/A converter which receives a digital data signal different from that of the D/A converters incorporated in the semiconductor integrated circuit to generate reference voltages and can selectively output reference voltages required for testing multiple kinds of semiconductor integrated circuits, in accordance with the selection of the digital data signal.

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Cheng discloses a D/A converter which receives a digital data signal different from that of the D/A converters incorporated in the semiconductor integrated circuit to generate reference voltages (see Cheng, col. 5 lines 57-59) and can selectively output reference voltages (see Cheng, col. 5 lines 59-60) required for testing multiple kinds of semiconductor integrated circuits, in accordance with the selection of the digital data signal (see Cheng, col. 6 lines 23-36).

Paulos et al. discloses selectively outputting a range of voltages based on a given input voltage (see Paulos et al., col. 3 lines 44-52).

It would have been obvious to one of ordinary skill in the art at the time the invention was made to modify the teachings of Yamagami et al. to include the teachings of Cheng because using a D/A converter as a voltage generator allows the skilled artisan to produce a continuous waveform (see Cheng, col. 4 lines 23-27), and to further include the teachings of Paulos et al. because outputting a set of voltages allows the expert artisan to effectively use the available supply voltage (see Paulos et al., col. 1 line 66 – col. 2 line 3).

5. Claims 3 and 4 are rejected under 35 U.S.C. 103(a) as being unpatentable over Yamagami et al. (U.S. Patent No. 6,121,786) in view of Ueno (U.S. Patent No. 5,818,210).

Referring to claim 3, Yamagami et al. discloses judging at one time whether all the amplified differential values obtained in the second step in association with respective output terminals fall within the first given voltage range (see Yamagami et al.,

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col. 12 line 65 – col. 13 line 3). Yamagami et al. does not teach calculating the difference between the reference voltage generated from the reference voltage generator or the testing device and the output voltage output from each output terminal, for all the output terminals; or amplifying the values obtained from the first step.

Ueno discloses calculating the difference between a predetermined voltage generated from the reference voltage generator or the testing device and the output voltage output from each output terminal, for all the output terminals (see Ueno, col. 3 lines 48-54 and Figure 2, "13a-c"), and amplifying the values obtained from the first step (see Ueno, col. 3 lines 50-54).

It would have been obvious at the time the invention was made to one of ordinary skill in the art to modify Yamagami et al. to include the teachings of Ueno, because using this method of calculating and amplifying the difference, a plurality of voltages can be generated (see Ueno, col. 5 lines 20-21).

Referring to claim 4, Yamagami et al. discloses that if the output from the device varies, the first given voltage range can be kept at constant by computing the difference between the output from the device under test and the associated reference voltage generated from the above reference voltage (see Yamagami et al., col. 12 line 56 – col. 13 line 3).

Conclusion

6. The prior art made of record and not relied upon is considered pertinent to applicant's disclosure.

Nguyen et al. teaches a method and apparatus for regulating the voltage supplied to an integrated circuit.

Yero teaches a Dynamically switchable reference voltage generator.

Hashimoto teaches a voltage applied type current measuring circuit in an IC testing apparatus.

Sieben et al. teaches a circuit and method for triggering an over-voltage protection unit.

Hayashi teaches an LCD panel test system and test method thereof.

Sugimoto et al. teaches an automatic testing method and testing apparatus for devices.

Takemoto teaches a display-driving voltage generating apparatus.

Haulin teaches a device for monitoring the supply voltage on integrated circuits.

8. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Mary Kate B Baran whose telephone number is (703) 305-4474. The examiner can normally be reached on Monday - Friday from 8:00 am to 5:00 pm.


If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Marc S Hoff can be reached on (703) 308-1677. The fax phone numbers for

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the organization where this application or proceeding is assigned are (703) 872-9318 for regular communications and (703) 872-9319 for After Final communications.

Any inquiry of a general nature or relating to the status of this application or proceeding should be directed to the receptionist whose telephone number is (703) 308-1782.

MKB
September 6, 2002


MARC S. HOFF
SUPERVISORY PATENT EXAMINER
TECHNOLOGY CENTER 2800